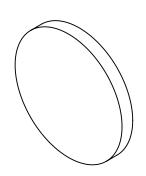
- 1. SUBSTRATE
- 2. SURFACE S2 TO BE PARALLEL WITH SURFACE S1 TO WITHIN 5 arcsec
- COATING (APPLY ACROSS COATING APERTURE) S1: HARD DIELECTRIC SPUTTERED T(avg): ≥91% FROM 408 - 1650nm @ 0° AOI T(avg): ≤0.01% FROM 200 - 390nm @ 0° AOI T(abs): =50% FOR 400±4nm @ 0° AOI

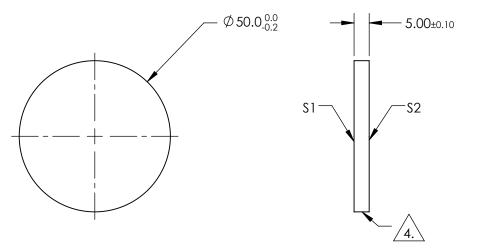
S2:SINGLE LAYER MgF2

## 4. FINE GRIND SURFACE

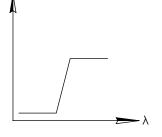
- 5. POWER, IRREGULARITY, AND SURFACE QUALITY SPECIFICATIONS APPLY ACROSS CLEAR APERTURE
- 6. TRANSMITTED WAVEFRONT DISTORTION, RMS: ≤λ/4 @ 633nm
- 7. ROHS COMPLIANT







6



LONGPASS FILTER

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LONGINGSTILLER						Edmund Optic	<b>C</b> ®
REV A	S1	S2					<i>,</i> 3
SHAPE	PLANO	PLANO				Ø50mm, 400nm, HIGH PERFORMAN	CF
SURFACE QUALITY	40-20	40-20	THIRD ANGLE . PROJECTION	THIRD ANGLE		LONGPASS FILTER	
CLEAR APERTURE	>80%	>80%		1			SHEET
BEVEL	PROTECTIVE AS NEEDED	PROTECTIVE AS NEEDED	ALL DIMS IN	mm	DWG NO	84754	1 OF 1

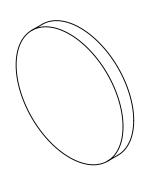
- 1. SUBSTRATE
- 2. SURFACE S2 TO BE PARALLEL WITH SURFACE S1 TO WITHIN 5 arcsec
- COATING (APPLY ACROSS COATING APERTURE) S1: HARD DIELECTRIC SPUTTERED T(avg): ≥91% FROM 458 - 1650nm @ 0° AOI T(avg): ≤0.01% FROM 200 - 440nm @ 0° AOI T(abs): =50% FOR 450±4.5nm @ 0° AOI

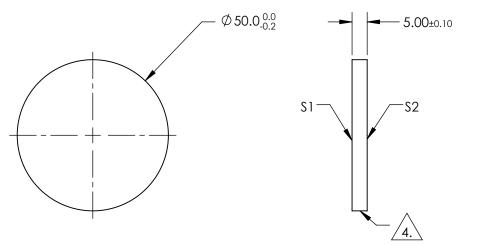
S2:SINGLE LAYER MgF2

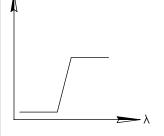
## 4. FINE GRIND SURFACE

- 5. POWER, IRREGULARITY, AND SURFACE QUALITY SPECIFICATIONS APPLY ACROSS CLEAR APERTURE
- 6. TRANSMITTED WAVEFRONT DISTORTION, RMS: ≤λ/4 @ 633nm
- 7. ROHS COMPLIANT









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LONGPASS FILTER			_		P	Edmund Optic	<b>C</b> ®
REV A	S1	S2					5
SHAPE	PLANO	PLANO				Ø50mm, 450nm, HIGH PERFORMAN	CF
SURFACE QUALITY	40-20	40-20			TITLE	LONGPASS FILTER	
CLEAR APERTURE	>80%	>80%		1			CULLET
BEVEL	PROTECTIVE AS NEEDED	PROTECTIVE AS NEEDED	ALL DIMS IN	mm	DWG NO	84755	SHEET 1 OF 1

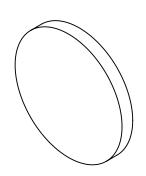
- 1. SUBSTRATE
- 2. SURFACE S2 TO BE PARALLEL WITH SURFACE S1 TO WITHIN 5 arcsec
- COATING (APPLY ACROSS COATING APERTURE) S1: HARD DIELECTRIC SPUTTERED T(avg): ≥91% FROM 508 - 1650nm @ 0° AOI T(avg): ≤0.01% FROM 200 - 490nm @ 0° AOI T(abs): =50% FOR 500±5nm @ 0° AOI

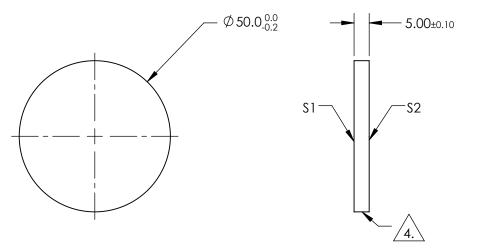
S2:SINGLE LAYER MgF2

## 4. FINE GRIND SURFACE

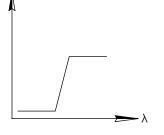
- 5. POWER, IRREGULARITY, AND SURFACE QUALITY SPECIFICATIONS APPLY ACROSS CLEAR APERTURE
- 6. TRANSMITTED WAVEFRONT DISTORTION, RMS: ≤λ/4 @ 633nm
- 7. ROHS COMPLIANT







6



LONGPASS FILTER

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LONGINGSTILLER					Edmund Optics <sup>®</sup>		
REV A	S1	S2				<sub>້</sub> ວ	
SHAPE	PLANO	PLANO			Ø50mm, 500nm, HIGH PERFORMANC	?Е	
SURFACE QUALITY	40-20	40-20	THIRD ANGLE	TITLE	LONGPASS FILTER		
CLEAR APERTURE	>80%	>80%					
BEVEL	PROTECTIVE AS NEEDED	PROTECTIVE AS NEEDED	ALL DIMS IN mm	DWG NO	84756	Sheet 1 Of 1	

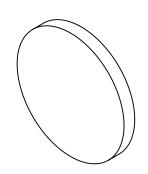
- 1. SUBSTRATE
- 2. SURFACE S2 TO BE PARALLEL WITH SURFACE S1 TO WITHIN 5 arcsec
- COATING (APPLY ACROSS COATING APERTURE) S1: HARD DIELECTRIC SPUTTERED T(avg): ≥91% FROM 560 - 1650nm @ 0° AOI T(avg): ≤0.01% FROM 200 - 539nm @ 0° AOI T(abs): =50% FOR 550±5.5nm @ 0° AOI

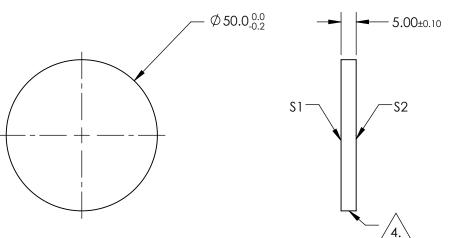
S2:SINGLE LAYER MgF2

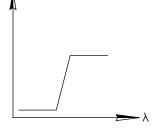
## 4. FINE GRIND SURFACE

- 5. POWER, IRREGULARITY, AND SURFACE QUALITY SPECIFICATIONS APPLY ACROSS CLEAR APERTURE
- 6. TRANSMITTED WAVEFRONT DISTORTION, RMS: ≤λ/4 @ 633nm
- 7. ROHS COMPLIANT









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LONGPASS FILTER			_			Edmund Optic	с®
REV A	S1	S2					5
SHAPE	PLANO	PLANO				Ø50mm, 550nm, HIGH PERFORMAN	CF
SURFACE QUALITY	40-20	40-20	THIRD ANGLE		TITLE	LONGPASS FILTER	
CLEAR APERTURE	>80%	>80%					
BEVEL	PROTECTIVE AS NEEDED	PROTECTIVE AS NEEDED	ALL DIMS IN	mm	DWG NO	84757	SHEET 1 OF 1

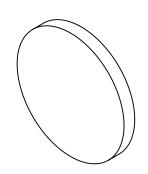
- 1. SUBSTRATE
- 2. SURFACE S2 TO BE PARALLEL WITH SURFACE S1 TO WITHIN 5 arcsec
- COATING (APPLY ACROSS COATING APERTURE) S1: HARD DIELECTRIC SPUTTERED T(avg): ≥91% FROM 610 - 1650nm @ 0° AOI T(avg): ≤0.01% FROM 200 - 588nm @ 0° AOI T(abs): =50% FOR 600±6nm @ 0° AOI

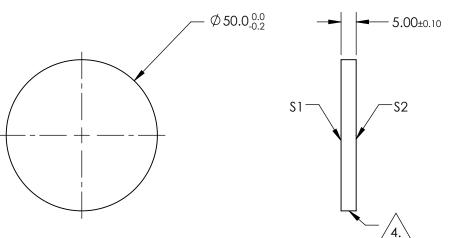
S2:SINGLE LAYER MgF2

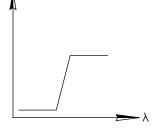
## 4. FINE GRIND SURFACE

- 5. POWER, IRREGULARITY, AND SURFACE QUALITY SPECIFICATIONS APPLY ACROSS CLEAR APERTURE
- 6. TRANSMITTED WAVEFRONT DISTORTION, RMS: ≤λ/4 @ 633nm
- 7. ROHS COMPLIANT









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LONGPASS FILTER			_	<b>Edmund Op</b>			
REV A	S1	S2					
SHAPE	PLANO	PLANO			Ø50mm, 600nm, HIGH PERFORMANCE		
SURFACE QUALITY	40-20	40-20		TITLE	LONGPASS FILTER		
CLEAR APERTURE	>80%	>80%					
BEVEL	PROTECTIVE AS NEEDED	PROTECTIVE AS NEEDED	ALL DIMS IN mm	DWG NO	84758 SHEET 1 OF 1		

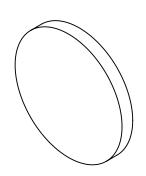
- 1. SUBSTRATE
- 2. SURFACE S2 TO BE PARALLEL WITH SURFACE S1 TO WITHIN 5 arcsec
- COATING (APPLY ACROSS COATING APERTURE) S1: HARD DIELECTRIC SPUTTERED T(avg): ≥91% FROM 660 - 1650nm @ 0° AOI T(avg): ≤0.01% FROM 200 - 637nm @ 0° AOI T(abs): =50% FOR 650±6.5nm @ 0° AOI

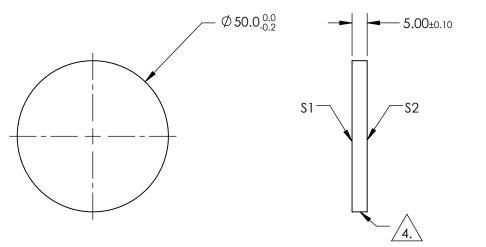
S2:SINGLE LAYER MgF2

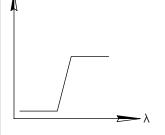
## 4. FINE GRIND SURFACE

- 5. POWER, IRREGULARITY, AND SURFACE QUALITY SPECIFICATIONS APPLY ACROSS CLEAR APERTURE
- 6. TRANSMITTED WAVEFRONT DISTORTION, RMS: ≤λ/4 @ 633nm
- 7. ROHS COMPLIANT









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LONGPASS FILTER					Edmund Optic	с®
REV A	S1	S2				<i>,</i> 3
SHAPE	PLANO	PLANO			Ø50mm, 650nm, HIGH PERFORMAN	CF
SURFACE QUALITY	40-20	40-20		TITLE	LONGPASS FILTER	
CLEAR APERTURE	>80%	>80%				
BEVEL	PROTECTIVE AS NEEDED	PROTECTIVE AS NEEDED	ALL DIMS IN mm	DWG NO	84759	SHEET 1 OF 1

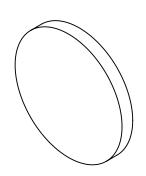
- 1. SUBSTRATE
- 2. SURFACE S2 TO BE PARALLEL WITH SURFACE S1 TO WITHIN 5 arcsec
- COATING (APPLY ACROSS COATING APERTURE) S1: HARD DIELECTRIC SPUTTERED T(avg): ≥91% FROM 710 - 1650nm @ 0° AOI T(avg): ≤0.01% FROM 200 - 686nm @ 0° AOI T(abs): =50% FOR 700±7nm @ 0° AOI

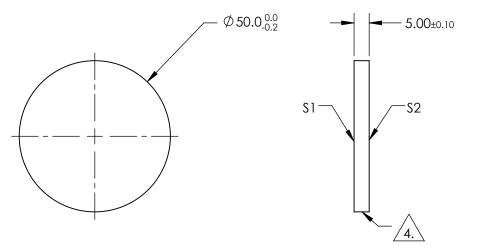
S2:SINGLE LAYER MgF2

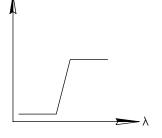
## 4. FINE GRIND SURFACE

- 5. POWER, IRREGULARITY, AND SURFACE QUALITY SPECIFICATIONS APPLY ACROSS CLEAR APERTURE
- 6. TRANSMITTED WAVEFRONT DISTORTION, RMS: ≤λ/4 @ 633nm
- 7. ROHS COMPLIANT









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LONGPASS FILTER							۲C®
REV A	S1	S2					5
SHAPE	PLANO	PLANO				Ø50mm, 700nm, HIGH PERFORMAN	ICE
SURFACE QUALITY	40-20	40-20	THIRD ANGLE		TITLE	LONGPASS FILTER	
CLEAR APERTURE	>80%	>80%		1			
BEVEL	PROTECTIVE AS NEEDED	PROTECTIVE AS NEEDED	ALL DIMS IN	mm	DWG NO	84760	SHEET 1 OF 1

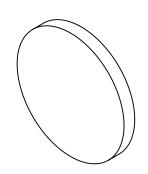
- 1. SUBSTRATE
- 2. SURFACE S2 TO BE PARALLEL WITH SURFACE S1 TO WITHIN 5 arcsec
- COATING (APPLY ACROSS COATING APERTURE) S1: HARD DIELECTRIC SPUTTERED T(avg): ≥91% FROM 765 - 1650nm @ 0° AOI T(avg): ≤0.01% FROM 200 - 735nm @ 0° AOI T(abs): =50% FOR 750±7.5nm @ 0° AOI

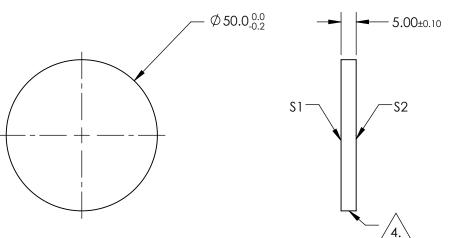
S2:SINGLE LAYER MgF2

## 4. FINE GRIND SURFACE

- 5. POWER, IRREGULARITY, AND SURFACE QUALITY SPECIFICATIONS APPLY ACROSS CLEAR APERTURE
- 6. TRANSMITTED WAVEFRONT DISTORTION, RMS: ≤λ/4 @ 633nm
- 7. ROHS COMPLIANT







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LONGPASS FILTER				Edmund Optic	۲ C®	
REV A	S1	S2				<i>,</i> 3
SHAPE	PLANO	PLANO			Ø50mm, 750nm, HIGH PERFORMAN	CF
SURFACE QUALITY	40-20	40-20		TITLE	LONGPASS FILTER	
CLEAR APERTURE	>80%	>80%				CULLET
BEVEL	PROTECTIVE AS NEEDED	PROTECTIVE AS NEEDED	ALL DIMS IN mm	DWG NO	84761	SHEET 1 OF 1

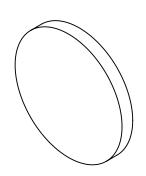
- 1. SUBSTRATE
- 2. SURFACE S2 TO BE PARALLEL WITH SURFACE S1 TO WITHIN 5 arcsec
- COATING (APPLY ACROSS COATING APERTURE) S1: HARD DIELECTRIC SPUTTERED T(avg): ≥91% FROM 815 - 1650nm @ 0° AOI T(avg): ≤0.01% FROM 200 - 785nm @ 0° AOI T(abs): =50% FOR 800±8nm @ 0° AOI

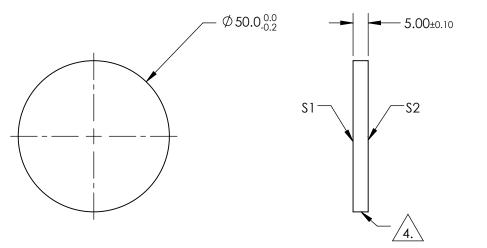
S2:SINGLE LAYER MgF2

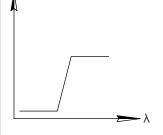
## 4. FINE GRIND SURFACE

- 5. POWER, IRREGULARITY, AND SURFACE QUALITY SPECIFICATIONS APPLY ACROSS CLEAR APERTURE
- 6. TRANSMITTED WAVEFRONT DISTORTION, RMS: ≤λ/4 @ 633nm
- 7. ROHS COMPLIANT









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LONGPASS FILTER			Edmund Opti				۲C®
REV A	S1	S2					5
SHAPE	PLANO	PLANO				Ø50mm, 800nm, HIGH PERFORMAN	ICE
SURFACE QUALITY	40-20	40-20	THIRD ANGLE		TITLE	LONGPASS FILTER	
CLEAR APERTURE	>80%	>80%		1			
BEVEL	PROTECTIVE AS NEEDED	PROTECTIVE AS NEEDED	ALL DIMS IN	mm	DWG NO	84762	SHEET 1 OF 1

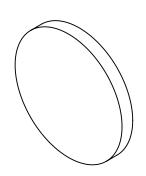
- 1. SUBSTRATE
- 2. SURFACE S2 TO BE PARALLEL WITH SURFACE S1 TO WITHIN 5 arcsec
- COATING (APPLY ACROSS COATING APERTURE) S1: HARD DIELECTRIC SPUTTERED T(avg): ≥91% FROM 865 - 1650nm @ 0° AOI T(avg): ≤0.01% FROM 200 - 835nm @ 0° AOI T(abs): =50% FOR 850±8.5nm @ 0° AOI

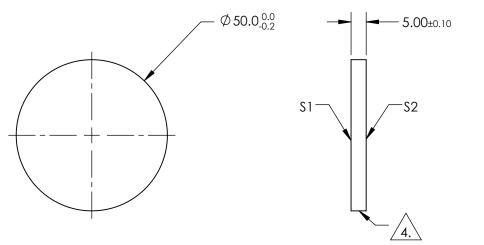
S2:SINGLE LAYER MgF2

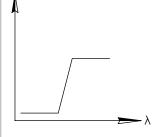
## 4. FINE GRIND SURFACE

- 5. POWER, IRREGULARITY, AND SURFACE QUALITY SPECIFICATIONS APPLY ACROSS CLEAR APERTURE
- 6. TRANSMITTED WAVEFRONT DISTORTION, RMS: ≤λ/4 @ 633nm
- 7. ROHS COMPLIANT









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LONGPASS FILTER			<b>P</b> Edmund C				۲C®
REV A	S1	S2					5
SHAPE	PLANO	PLANO				Ø50mm, 850nm, HIGH PERFORMAN	ICE
SURFACE QUALITY	40-20	40-20	THIRD ANGLE		TITLE	LONGPASS FILTER	
CLEAR APERTURE	>80%	>80%					
BEVEL	PROTECTIVE AS NEEDED	PROTECTIVE AS NEEDED	ALL DIMS IN	mm	DWG NO	84763	SHEET 1 OF 1

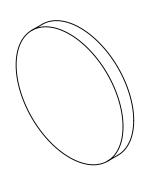
- 1. SUBSTRATE
- 2. SURFACE S2 TO BE PARALLEL WITH SURFACE S1 TO WITHIN 5 arcsec
- COATING (APPLY ACROSS COATING APERTURE) S1: HARD DIELECTRIC SPUTTERED T(avg): ≥91% FROM 915 - 1650nm @ 0° AOI T(avg): ≤0.01% FROM 200 - 880nm @ 0° AOI T(abs): =50% FOR 900±9nm @ 0° AOI

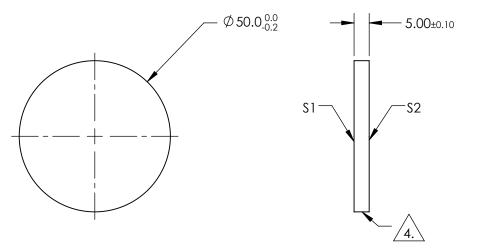
S2:SINGLE LAYER MgF2

## 4. FINE GRIND SURFACE

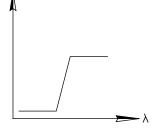
- 5. POWER, IRREGULARITY, AND SURFACE QUALITY SPECIFICATIONS APPLY ACROSS CLEAR APERTURE
- 6. TRANSMITTED WAVEFRONT DISTORTION, RMS: ≤λ/4 @ 633nm
- 7. ROHS COMPLIANT







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LONGPASS FILTER

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LONGI / 03 HETEK					Edmund Optics <sup>®</sup>	
REV A	S1	\$2				
SHAPE	PLANO	PLANO			Ø50mm, 900nm, HIGH PERFORMANCE	
SURFACE QUALITY	40-20	40-20		TITLE	LONGPASS FILTER	
CLEAR APERTURE	>80%	>80%			SHEET	
BEVEL	PROTECTIVE AS NEEDED	PROTECTIVE AS NEEDED	ALL DIMS IN mm	DWG NO	84764 SHEET 1 OF 1	

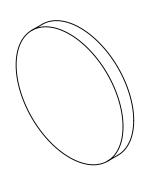
- 1. SUBSTRATE
- 2. SURFACE S2 TO BE PARALLEL WITH SURFACE S1 TO WITHIN 5 arcsec
- COATING (APPLY ACROSS COATING APERTURE) S1: HARD DIELECTRIC SPUTTERED T(avg): ≥91% FROM 965 - 1650nm @ 0° AOI T(avg): ≤0.01% FROM 200 - 930nm @ 0° AOI T(abs): =50% FOR 950±9.5nm @ 0° AOI

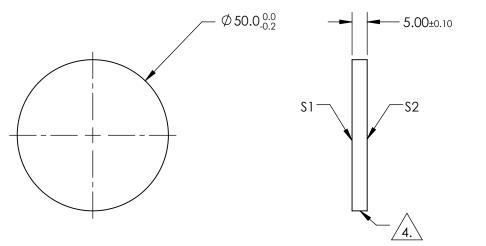
S2:SINGLE LAYER MgF2

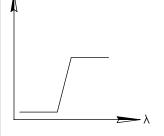
## 4. FINE GRIND SURFACE

- 5. POWER, IRREGULARITY, AND SURFACE QUALITY SPECIFICATIONS APPLY ACROSS CLEAR APERTURE
- 6. TRANSMITTED WAVEFRONT DISTORTION, RMS: ≤λ/4 @ 633nm
- 7. ROHS COMPLIANT









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LONGPASS FILTER					<sup>®</sup> Edmund Optics <sup>®</sup>
REV A	S1	S2			
SHAPE	PLANO	PLANO			Ø50mm, 950nm, HIGH PERFORMANCE
SURFACE QUALITY	40-20	40-20		TITLE	LONGPASS FILTER
CLEAR APERTURE	>80%	>80%			
BEVEL	PROTECTIVE AS NEEDED	PROTECTIVE AS NEEDED	ALL DIMS IN mm	DWG NO	84765 SHEET 1 OF 1

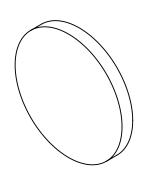
- 1. SUBSTRATE
- 2. SURFACE S2 TO BE PARALLEL WITH SURFACE S1 TO WITHIN 5 arcsec
- COATING (APPLY ACROSS COATING APERTURE) S1: HARD DIELECTRIC SPUTTERED T(avg): ≥91% FROM 1020 - 1650nm @ 0° AOI T(avg): ≤0.01% FROM 200 - 980nm @ 0° AOI T(abs): =50% FOR 1000±10nm @ 0° AOI

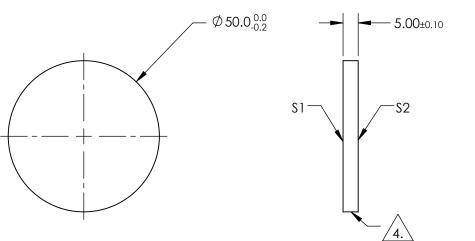
S2:SINGLE LAYER MgF2

## 4. FINE GRIND SURFACE

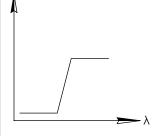
- 5. POWER, IRREGULARITY, AND SURFACE QUALITY SPECIFICATIONS APPLY ACROSS CLEAR APERTURE
- 6. TRANSMITTED WAVEFRONT DISTORTION, RMS: ≤λ/4 @ 633nm
- 7. ROHS COMPLIANT







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LONGPASS FILTER

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LONGINGOHEIER			_			<sup>®</sup> Edmund Optics <sup>®</sup>
REV A	S1	S2				
SHAPE	PLANO	PLANO		1		Ø50mm, 1000nm, HIGH PERFORMANCE
SURFACE QUALITY	40-20	40-20	THIRD ANGLE _ PROJECTION	$\bigcirc \bigcirc$	TITLE	LONGPASS FILTER
CLEAR APERTURE	>80%	>80%		1		
BEVEL	PROTECTIVE AS NEEDED	PROTECTIVE AS NEEDED	ALL DIMS IN	mm	DWG NO	84766 SHEET 1 OF 1

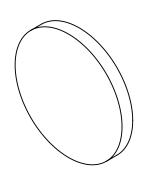
- 1. SUBSTRATE
- 2. SURFACE S2 TO BE PARALLEL WITH SURFACE S1 TO WITHIN 5 arcsec
- COATING (APPLY ACROSS COATING APERTURE) S1: HARD DIELECTRIC SPUTTERED T(avg): ≥91% FROM 1070 - 1650nm @ 0° AOI T(avg): ≤0.01% FROM 200 - 1030nm @ 0° AOI T(abs): =50% FOR 1050±10.5nm @ 0° AOI

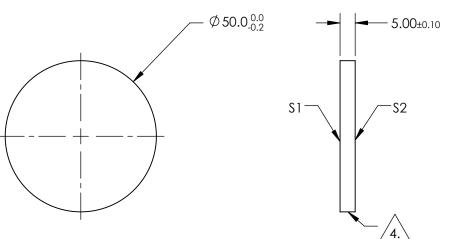
S2:SINGLE LAYER MgF2

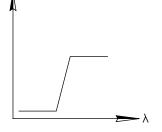
## 4. FINE GRIND SURFACE

- 5. POWER, IRREGULARITY, AND SURFACE QUALITY SPECIFICATIONS APPLY ACROSS CLEAR APERTURE
- 6. TRANSMITTED WAVEFRONT DISTORTION, RMS: ≤λ/4 @ 633nm
- 7. ROHS COMPLIANT









Τ

LONGPASS FILTER			_			Edmund Optic	<b>C</b> ®
REV A	S1	S2					5
SHAPE	PLANO	PLANO				Ø50mm, 1050nm, HIGH PERFORMANCE LONGPASS FILTER	
SURFACE QUALITY	40-20	40-20			- TITLE		
CLEAR APERTURE	>80%	>80%		1			SULLET
BEVEL	PROTECTIVE AS NEEDED	PROTECTIVE AS NEEDED	ALL DIMS IN	mm	DWG NO	84767	SHEET 1 OF 1

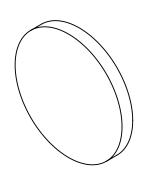
- 1. SUBSTRATE
- 2. SURFACE S2 TO BE PARALLEL WITH SURFACE S1 TO WITHIN 5 arcsec
- COATING (APPLY ACROSS COATING APERTURE) S1: HARD DIELECTRIC SPUTTERED T(avg): ≥91% FROM 1120 - 1650nm @ 0° AOI T(avg): ≤0.01% FROM 200 - 1080nm @ 0° AOI T(abs): =50% FOR 1100±11nm @ 0° AOI

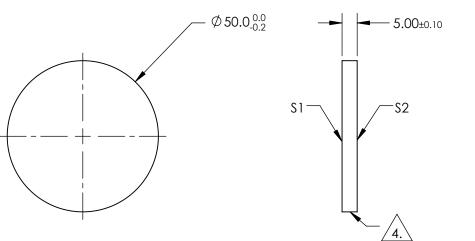
S2:SINGLE LAYER MgF2

## 4. FINE GRIND SURFACE

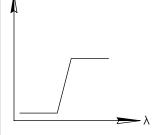
- 5. POWER, IRREGULARITY, AND SURFACE QUALITY SPECIFICATIONS APPLY ACROSS CLEAR APERTURE
- 6. TRANSMITTED WAVEFRONT DISTORTION, RMS: ≤λ/4 @ 633nm
- 7. ROHS COMPLIANT







6



LONGPASS FILTER

Т

LONGINGSTIELER					<sup>®</sup> Edmund Optics <sup>®</sup>
REV A	S1	\$2			
SHAPE	PLANO	PLANO			Ø50mm, 1100nm, HIGH PERFORMANCE
SURFACE QUALITY	40-20	40-20		TITLE	LONGPASS FILTER
CLEAR APERTURE	>80%	>80%			
BEVEL	PROTECTIVE AS NEEDED	PROTECTIVE AS NEEDED	ALL DIMS IN mm	DWG NO	84768 SHEET 1 OF 1